TOSHIBA Field Effect Transistor Silicon P Channel MOS Type ( $L^2-\pi$ -MOSV)

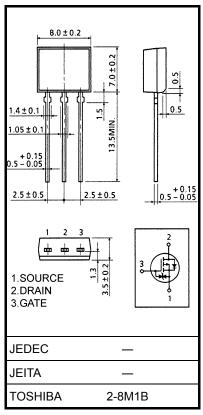
# 2SJ378

Relay Drive, DC–DC Converter and Motor Drive Applications

- 4-V gate drive
- Low drain-source ON resistance  $: R_{DS}(ON) = 0.16 \Omega$  (typ.)
- High forward transfer admittance  $|Y_{fs}| = 4.0 \text{ S (typ.)}$
- Low leakage current  $: I_{DSS} = -100 \ \mu A \ (max) \ (V_{DS} = -60 \ V)$
- Enhancement mode :  $V_{th} = -0.8 \sim -2.0 V (V_{DS} = -10 V, I_D = -1 mA)$

#### Absolute Maximum Ratings (Ta = 25°C)

| Characteristics                              |               | Symbol           | Rating  | Unit |  |
|----------------------------------------------|---------------|------------------|---------|------|--|
| Drain-source voltage                         |               | V <sub>DSS</sub> | -60     | V    |  |
| Drain-gate voltage (R <sub>GS</sub> = 20 kΩ) |               | V <sub>DGR</sub> | -60     | V    |  |
| Gate-source voltage                          |               | V <sub>GSS</sub> | ±20     | V    |  |
| Drain current                                | DC (Note 1)   | ۱ <sub>D</sub>   | -5      | А    |  |
|                                              | Pulse(Note 1) | I <sub>DP</sub>  | -20     | А    |  |
| Drain power dissipatio                       | n             | PD               | 1.3     | W    |  |
| Single pulse avalanche energy<br>(Note 2)    |               | E <sub>AS</sub>  | 273     | mJ   |  |
| Avalanche current                            |               | I <sub>AR</sub>  | -5      | А    |  |
| Repetitive avalenche energy (Note 3)         |               | E <sub>AR</sub>  | 0.13    | mJ   |  |
| Channel temperature                          |               | T <sub>ch</sub>  | 150     | °C   |  |
| Storage temperature range                    |               | T <sub>stg</sub> | -55~150 | °C   |  |



Weight: 0.54 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### **Thermal Characteristics**

| Characteristics                        | Symbol                 | Max  | Unit   |
|----------------------------------------|------------------------|------|--------|
| Thermal resistance, channel to ambient | R <sub>th (ch−a)</sub> | 96.1 | °C / W |

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:  $V_{DD}$  = -25 V,  $T_{ch}$  = 25°C (initial), L = 14.84 mH,  $R_G$  = 25  $\Omega$ ,  $I_{AR}$  = -5 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Please handle with caution. Unit: mm

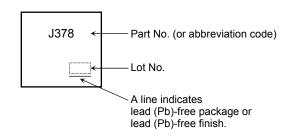
Electrical Characteristics (Ta = 25°C)

| Charao                                          | cteristics      | Symbol               | Test Condition                                                                                                                           | Min  | Тур. | Max  | Unit      |
|-------------------------------------------------|-----------------|----------------------|------------------------------------------------------------------------------------------------------------------------------------------|------|------|------|-----------|
| Gate leakage cu                                 | ırrent          | I <sub>GSS</sub>     | V <sub>GS</sub> = ±16 V, V <sub>DS</sub> = 0 V                                                                                           |      | _    | ±10  | μA        |
| Drain cut-off cu                                | rrent           | I <sub>DSS</sub>     | V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0 V                                                                                           |      |      | -100 | μA        |
| Drain-source br                                 | eakdown voltage | V (BR) DSS           | I <sub>D</sub> = -10 mA, V <sub>GS</sub> = 0 V                                                                                           | -60  | _    | _    | V         |
| Gate threshold                                  | voltage         | V <sub>th</sub>      | $V_{DS} = -10 \text{ V}, \text{ I}_{D} = -1 \text{ mA}$                                                                                  | -0.8 | _    | -2.0 | V         |
| Drain-source ON resistance                      |                 | R <sub>DS (ON)</sub> | V <sub>GS</sub> = -4 V, I <sub>D</sub> = -2.5 A                                                                                          | -    | 0.24 | 0.28 | Ω         |
|                                                 |                 |                      | $V_{GS}$ = -10 V, I <sub>D</sub> = -2.5 A                                                                                                |      | 0.16 | 0.19 | 12        |
| Forward transfe                                 | r admittance    | Y <sub>fs</sub>      | $V_{DS}$ = -10 V, I <sub>D</sub> = -2.5 A                                                                                                | 2.0  | 4.0  | _    | S         |
| Input capacitance                               | ce              | C <sub>iss</sub>     |                                                                                                                                          | -    | 630  | _    |           |
| Reverse transfer capacitance                    |                 | C <sub>rss</sub>     | $\frac{C_{rss}}{C_{oss}}$ V <sub>DS</sub> = -10 V, V <sub>GS</sub> = 0 V, f = 1 MHz                                                      |      | 95   | _    | pF        |
| Output capacitance                              |                 | C <sub>oss</sub>     |                                                                                                                                          | _    | 290  | _    |           |
| Switching time                                  | Rise time       | tr                   | $V_{GS} \stackrel{0V}{\longrightarrow} I_{D} = -2.5A$ $V_{OUT} \stackrel{V}{\longrightarrow} V_{OUT}$ $R_{L} = 12\Omega$ $V_{DD} = -30V$ | _    | 25   | _    |           |
|                                                 | Turn-on time    | t <sub>on</sub>      |                                                                                                                                          | _    | 45   | _    | 20        |
|                                                 | Fall time       | t <sub>f</sub>       |                                                                                                                                          |      | 55   | _    | – ns<br>– |
|                                                 | Turn-off time   | t <sub>off</sub>     | Duty $\leq 1\%$ , t <sub>w</sub> =10 $\mu$ s                                                                                             |      | 200  | _    |           |
| Total gate charge (Gate-source plus gate-drain) |                 | Qg                   |                                                                                                                                          | _    | 22   | —    |           |
| Gate-source charge                              |                 | Q <sub>gs</sub>      | V <sub>DD</sub> ≈ −48 V, V <sub>GS</sub> = −10 V, I <sub>D</sub> = −5 A                                                                  |      | 16   | —    | nC        |
| Gate-drain ("miller") charge                    |                 | Q <sub>gd</sub>      |                                                                                                                                          |      | 6    | —    |           |

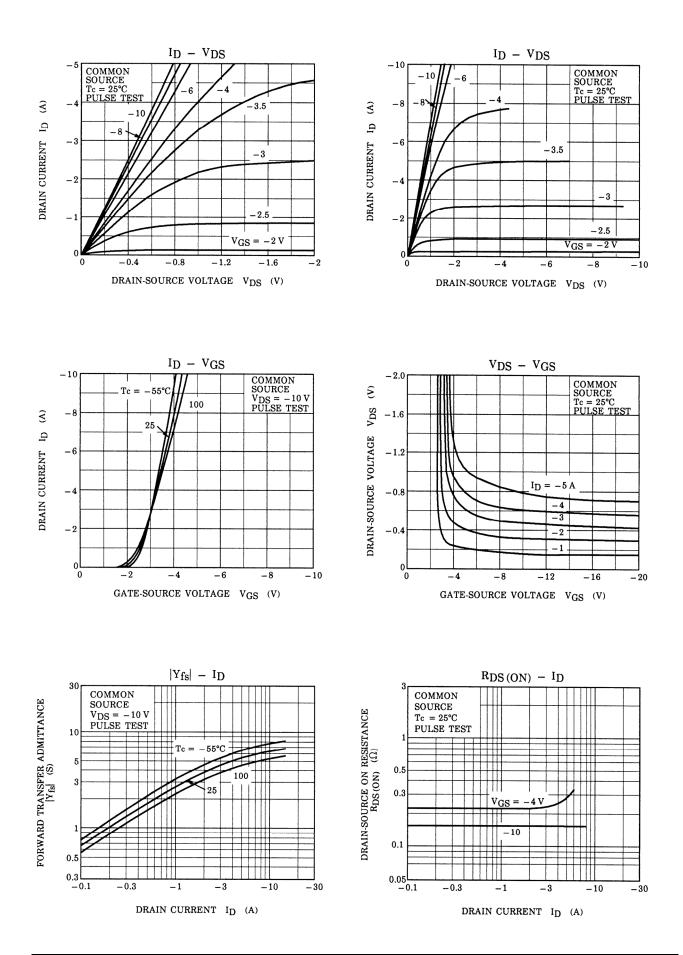
## Source–Drain Ratings and Characteristics (Ta = 25°C)

| Characteristics                              | Symbol           | Test Condition                                | Min | Тур. | Max | Unit |
|----------------------------------------------|------------------|-----------------------------------------------|-----|------|-----|------|
| Continuous drain reverse current<br>(Note 1) | I <sub>DR</sub>  | —                                             | _   | _    | -5  | А    |
| Pulse drain reverse current<br>(Note 1)      | I <sub>DRP</sub> | —                                             | _   | _    | -20 | А    |
| Forward voltage (diode)                      | V <sub>DSF</sub> | I <sub>DR</sub> = -5 A, V <sub>GS</sub> = 0 V | _   | _    | 1.7 | V    |
| Reverse recovery time                        | t <sub>rr</sub>  | I <sub>DR</sub> = -5 A, V <sub>GS</sub> = 0 V | _   | 80   | _   | ns   |
| Reverse recovery charge                      | Qrr              | $dI_{DR} / dt = 50 \text{ A} / \mu \text{S}$  | _   | 0.1  |     | μC   |

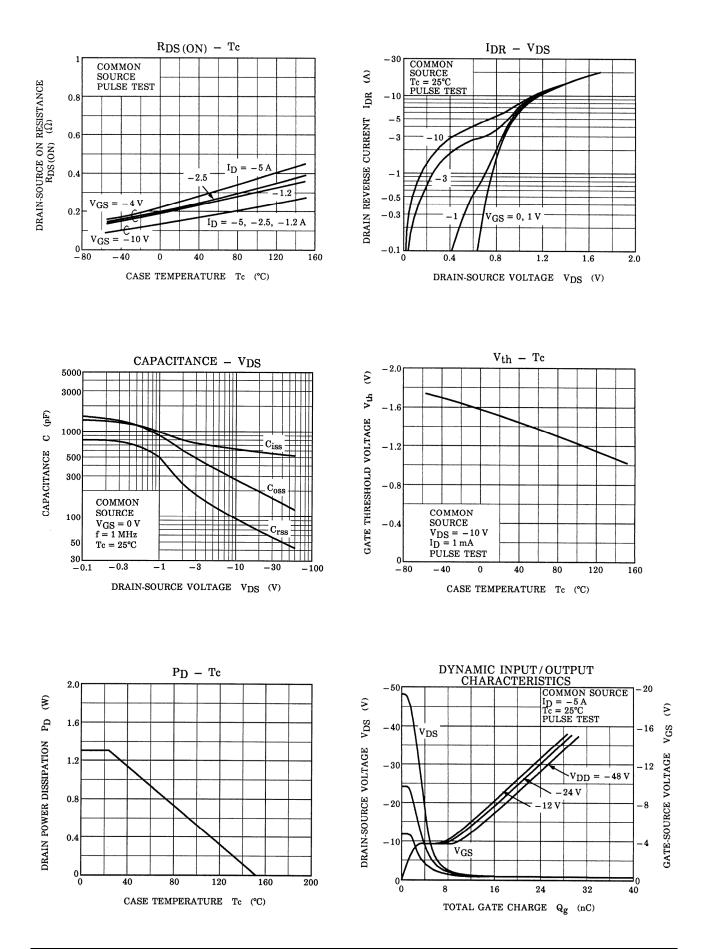
## Marking

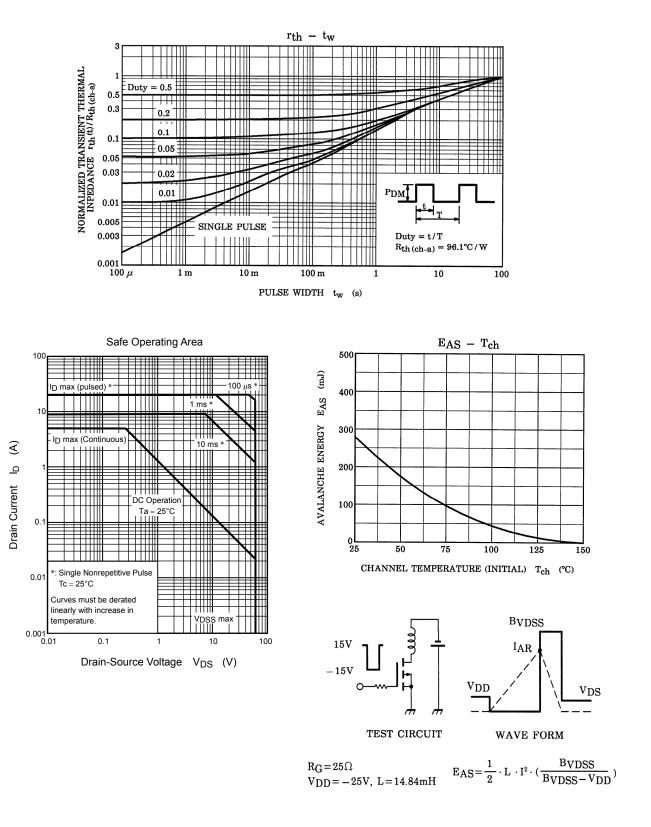


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